## Issue Classification

/Ha Nguyen/

(Primary Examiner)

Roberto Velez

Application/Control No.	Applicant(s)/Patent Under Reexamination								
10830220	YOSHIDA ET AL.								
Examiner	Art Unit								

2829

ORIGINAL						INTERNATIONAL CLASSIFICATION										
CLASS SUE				SUBCLASS	CLASS				С	LAIMED	NON-CLAIMED					
324			761			G	0	1	R	31 / 02 (2006.0	1.01)					
CROSS REFERENCE(S)			S)													
CLASS SUBCLASS (ONE SUBCLASS PER BLOCK)																
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/Roberto Velez/ 07/17/2008  (Assistant Examiner) (Date)						Total Claims Allo										

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O.G. Print Claim(s)

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O.G. Print Figure

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